Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10715045	SENDYK ET AL.
Examiner	Art Unit

2618

SEARCHED			
Class	Subclass	Date	Examiner

YUWEN PAN

SEARCH NOTES		
Search Notes	Date	Examiner
updated search	6/23/09	YP

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

U.S. Patent and Trademark Office Part of Paper No.: 20090623